



M24C16, M24C08 M24C04, M24C02, M24C01

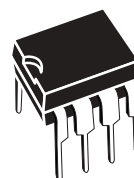
16 Kbit, 8 Kbit, 4 Kbit, 2 Kbit and 1 Kbit serial I²C bus EEPROM

Features

- Two-wire I²C serial interface
Supports 400 kHz protocol
- Single supply voltage:
 - 2.5 V to 5.5 V for M24Cxx-W
 - 1.8 V to 5.5 V for M24Cxx-R
 - 1.7 V to 5.5 V for M24Cxx-F
- Write Control input
- Byte and Page Write (up to 16 bytes)
- Random and Sequential Read modes
- Self-timed programming cycle
- Automatic address incrementing
- Enhanced ESD/latch-up protection
- More than 1 million write cycles
- More than 40-year data retention
- Packages
 - ECOPACK® (RoHS compliant)

Table 1. Device summary

Reference	Part number
M24C16	M24C16-W
	M24C16-R
	M24C16-F
M24C08	M24C08-W
	M24C08-R
	M24C08-F
M24C04	M24C04-W
	M24C04-R
	M24C04-F
M24C02	M24C02-W
	M24C02-R
M24C01	M24C01-W
	M24C01-R



PDIP8 (BN)



SO8 (MN)
150 mils width



TSSOP8 (DW)
169 mils width



TSSOP8 (DS)
3 x 3 mm body size



UFD8 (MB)
2 x 3 mm (MLP)

Contents

1	Description	6
2	Signal description	8
2.1	Serial Clock (SCL)	8
2.2	Serial Data (SDA)	8
2.3	Chip Enable (E0, E1, E2)	8
2.3.1	Write Control (WC)	8
2.4	Supply voltage (V_{CC})	9
2.4.1	Operating supply voltage V_{CC}	9
2.4.2	Power-up conditions	9
2.4.3	Device reset	9
2.4.4	Power-down conditions	9
3	Device operation	11
3.1	Start condition	11
3.2	Stop condition	11
3.3	Acknowledge Bit (ACK)	11
3.4	Data input	11
3.5	Memory addressing	12
3.6	Write operations	13
3.6.1	Byte Write	13
3.6.2	Page Write	14
3.6.3	Minimizing system delays by polling on ACK	15
3.7	Read operations	16
3.7.1	Random Address Read	16
3.7.2	Current Address Read	17
3.7.3	Sequential Read	17
3.7.4	Acknowledge in Read mode	17
4	Initial delivery state	18
5	Maximum rating	18
6	DC and AC parameters	19

7	Package mechanical	25
8	Part numbering	30
9	Revision history	32

List of tables

Table 1.	Device summary	1
Table 2.	Signal names	6
Table 3.	Device select code	10
Table 4.	Operating modes	12
Table 5.	Absolute maximum ratings	18
Table 6.	Operating conditions (M24Cxx-W)	19
Table 7.	Operating conditions (M24Cxx-R)	19
Table 8.	Operating conditions (M24Cxx-F)	19
Table 9.	DC characteristics (M24Cxx-W, device grade 6)	19
Table 10.	DC characteristics (M24Cxx-W, device grade 3)	20
Table 11.	DC characteristics (M24Cxx-R)	20
Table 12.	DC characteristics (M24Cxx-F)	21
Table 13.	AC measurement conditions.	21
Table 14.	Input parameters.	21
Table 15.	AC characteristics (M24Cxx-W)	22
Table 16.	AC characteristics (M24Cxx-R and M24Cxx-F)	23
Table 17.	PDIP8 – 8 pin plastic DIP, 0.25 mm lead frame, package mechanical data.	25
Table 18.	SO8 narrow – 8 lead plastic small outline, 150 mils body width, package mechanical data.	26
Table 19.	UFDFPN8 (MLP8) 8-lead ultra thin fine pitch dual flat package no lead 2 x 3 mm, data	27
Table 20.	TSSOP8 – 8 lead thin shrink small outline, package mechanical data.	28
Table 21.	TSSOP8 3 x 3 mm – 8 lead thin shrink small outline, 3 x 3 mm body size, mechanical data	29
Table 22.	Ordering information scheme	30
Table 23.	Available M24C16 products (package, voltage range, temperature grade)	31
Table 24.	Available M24C08 products (package, voltage range, temperature grade)	31
Table 25.	Available M24C04 products (package, voltage range, temperature grade)	31
Table 26.	Available M24C02 products (package, voltage range, temperature grade)	31
Table 27.	Available M24C01 products (package, voltage range, temperature grade)	31
Table 28.	Document revision history	32

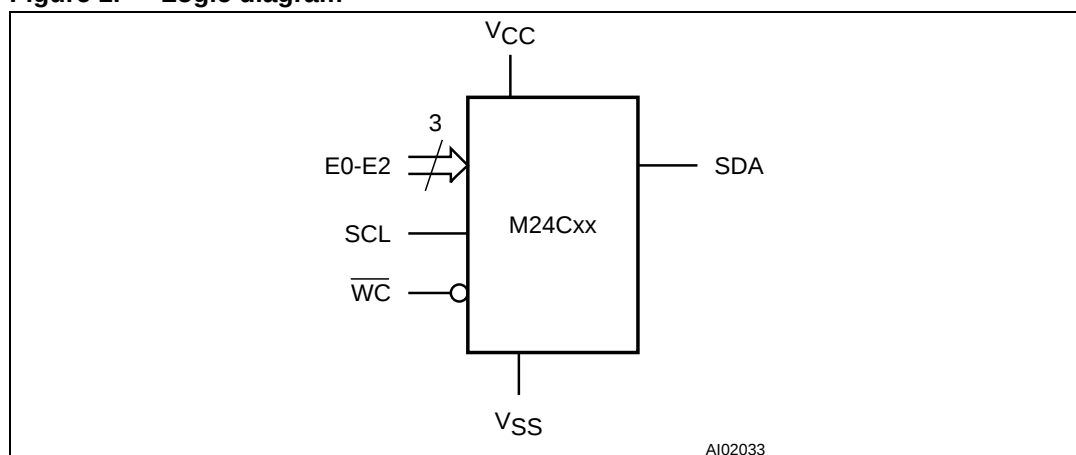
1 Description

These I²C-compatible electrically erasable programmable memory (EEPROM) devices are organized as 2048/1024/512/256/128 x 8 (M24C16, M24C08, M24C04, M24C02 and M24C01).

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. ECOPACK® packages are Lead-free and RoHS compliant.

ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com.

Figure 1. Logic diagram



I²C uses a two-wire serial interface, comprising a bidirectional data line and a clock line. The devices carry a built-in 4-bit Device Type Identifier code (1010) in accordance with the I²C bus definition.

The device behaves as a slave in the I²C protocol, with all memory operations synchronized by the serial clock. Read and Write operations are initiated by a Start condition, generated by the bus master. The Start condition is followed by a device select code and Read/Write bit ($\overline{RW}$) (as described in [Table 3](#)), terminated by an acknowledge bit.

When writing data to the memory, the device inserts an acknowledge bit during the 9th bit time, following the bus master's 8-bit transmission. When data is read by the bus master, the bus master acknowledges the receipt of the data byte in the same way. Data transfers are terminated by a Stop condition after an Ack for Write, and after a NoAck for Read.

Table 2. Signal names

Signal name	Function	Direction
E0, E1, E2	Chip Enable	Input
SDA	Serial Data	Input/output
SCL	Serial Clock	Input
$\overline{WC}$	Write Control	Input
V _{CC}	Supply voltage	
V _{SS}	Ground	

2 Signal description

2.1 Serial Clock (SCL)

This input signal is used to strobe all data in and out of the device. In applications where this signal is used by slave devices to synchronize the bus to a slower clock, the bus master must have an open drain output, and a pull-up resistor can be connected from Serial Clock (SCL) to V_{CC} . (Figure 4 indicates how the value of the pull-up resistor can be calculated). In most applications, though, this method of synchronization is not employed, and so the pull-up resistor is not necessary, provided that the bus master has a push-pull (rather than open drain) output.

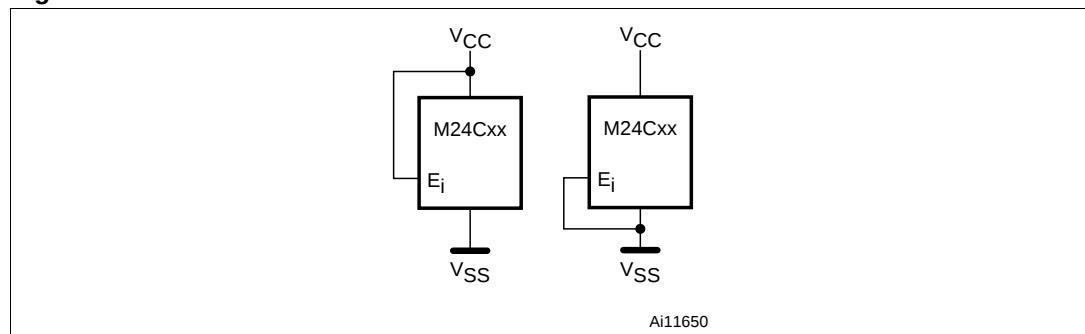
2.2 Serial Data (SDA)

This bidirectional signal is used to transfer data in or out of the device. It is an open drain output that may be wire-OR'ed with other open drain or open collector signals on the bus. A pull up resistor must be connected from Serial Data (SDA) to V_{CC} . (Figure 4 indicates how the value of the pull-up resistor can be calculated).

2.3 Chip Enable (E0, E1, E2)

These input signals are used to set the value that is to be looked for on the three least significant bits (b3, b2, b1) of the 7-bit device select code. These inputs must be tied to V_{CC} or V_{SS} , to establish the device select code as shown in Figure 3. When not connected (left floating), E0, E1, E2 are read as low (0,0,0).

Figure 3. Device select code



2.3.1 Write Control ($\overline{WC}$)

This input signal is useful for protecting the entire contents of the memory from inadvertent write operations. Write operations are disabled to the entire memory array when Write Control ($\overline{WC}$) is driven High. When unconnected, the signal is internally read as V_{IL} , and Write operations are allowed.

When Write Control ($\overline{WC}$) is driven High, device select and address bytes are acknowledged, data bytes are not acknowledged.

Figure 5. I²C bus protocol

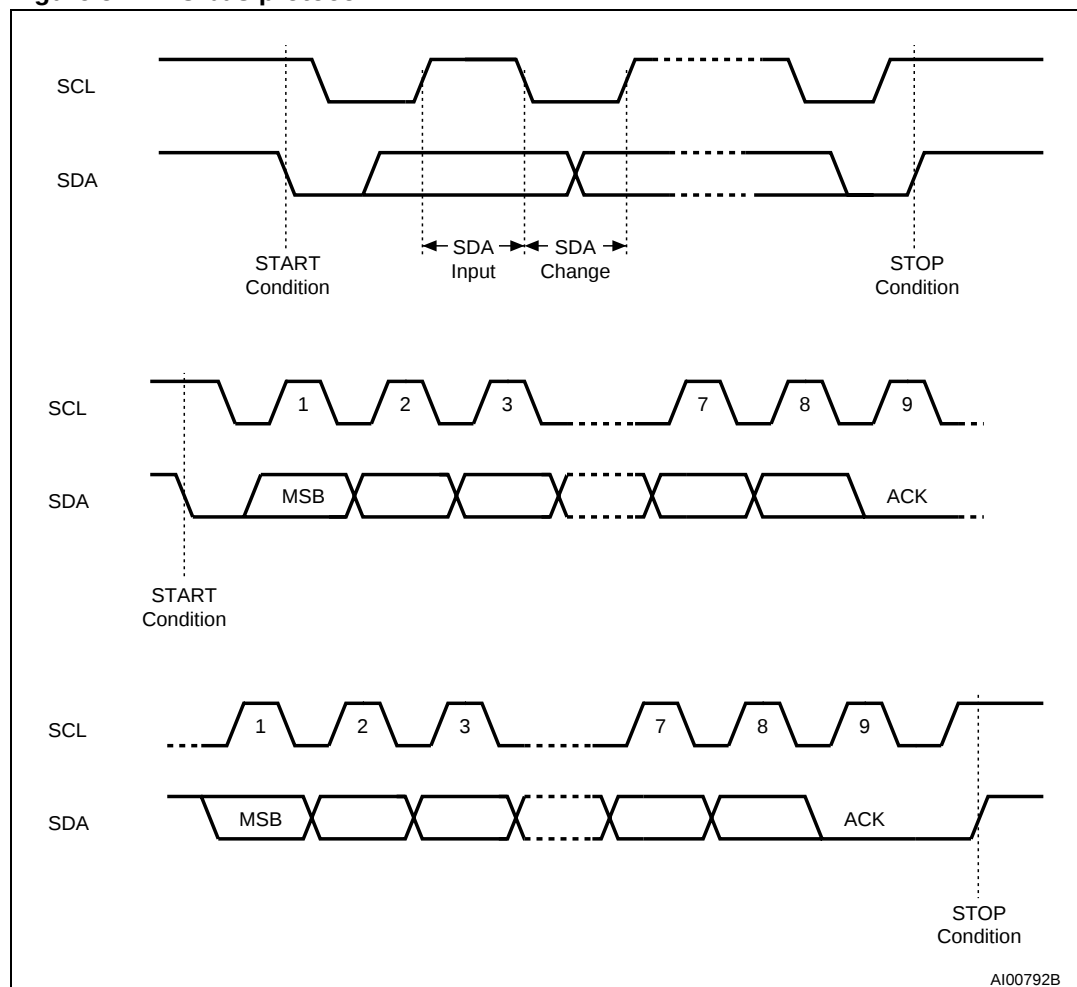


Table 3. Device select code

	Device type identifier ⁽¹⁾				Chip Enable ^{(2),(3)}			R $\overline{W}$
	b7	b6	b5	b4	b3	b2	b1	b0
M24C01 select code	1	0	1	0	E2	E1	E0	R $\overline{W}$
M24C02 select code	1	0	1	0	E2	E1	E0	R $\overline{W}$
M24C04 select code	1	0	1	0	E2	E1	A8	R $\overline{W}$
M24C08 select code	1	0	1	0	E2	A9	A8	R $\overline{W}$
M24C16 select code	1	0	1	0	A10	A9	A8	R $\overline{W}$

1. The most significant bit, b7, is sent first.
2. E0, E1 and E2 are compared against the respective external pins on the memory device.
3. A10, A9 and A8 represent most significant bits of the address.

3.5 Memory addressing

To start communication between the bus master and the slave device, the bus master must initiate a Start condition. Following this, the bus master sends the device select code, shown in [Table 3](#) (on Serial Data (SDA), most significant bit first).

The device select code consists of a 4-bit Device Type Identifier, and a 3-bit Chip Enable "Address" (E2, E1, E0). To address the memory array, the 4-bit Device Type Identifier is 1010b.

Each device is given a unique 3-bit code on the Chip Enable (E0, E1, E2) inputs. When the device select code is received, the device only responds if the Chip Enable Address is the same as the value on the Chip Enable (E0, E1, E2) inputs. However, those devices with larger memory capacities (the M24C16, M24C08 and M24C04) need more address bits. E0 is not available for use on devices that need to use address line A8; E1 is not available for devices that need to use address line A9, and E2 is not available for devices that need to use address line A10 (see [Figure 2](#) and [Table 3](#) for details). Using the E0, E1 and E2 inputs, up to eight M24C02 (or M24C01), four M24C04, two M24C08 or one M24C16 devices can be connected to one I²C bus. In each case, and in the hybrid cases, this gives a total memory capacity of 16 Kbits, 2 KBytes (except where M24C01 devices are used).

The 8th bit is the Read/Write bit ($\overline{RW}$). This bit is set to 1 for Read and 0 for Write operations.

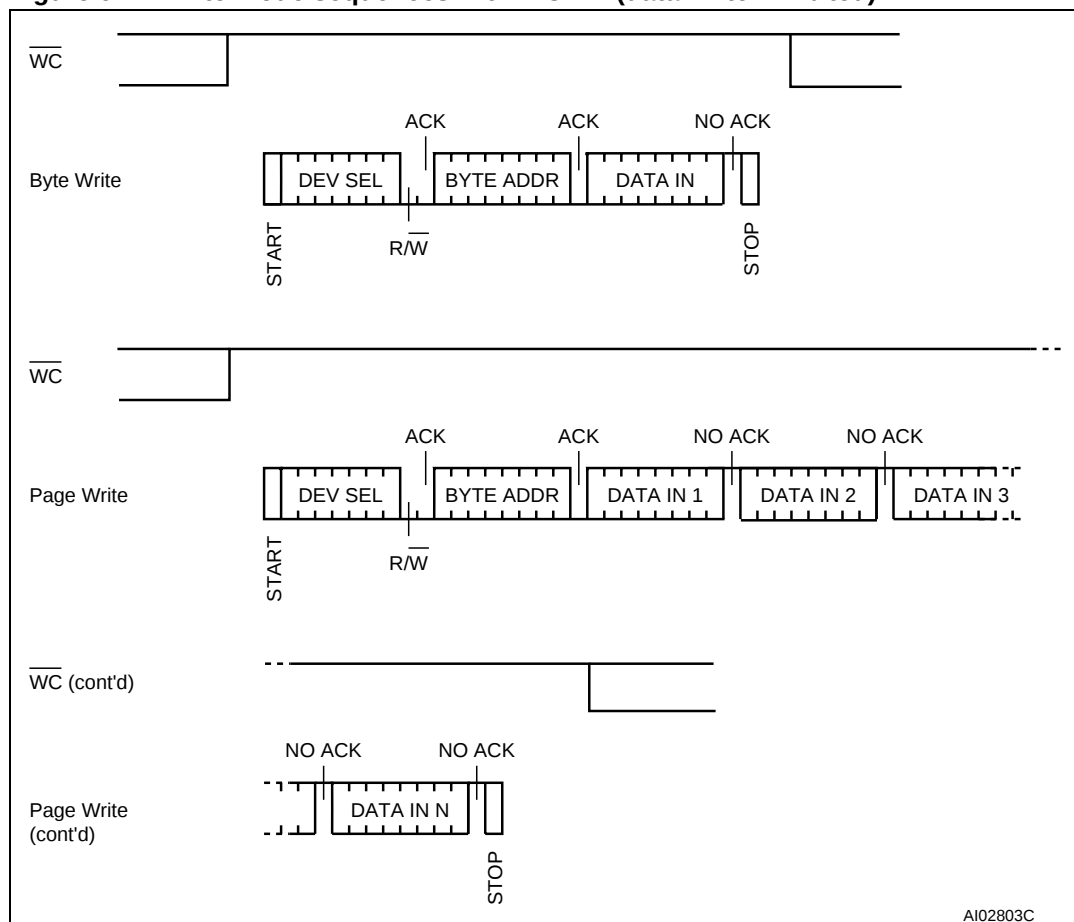
If a match occurs on the device select code, the corresponding device gives an acknowledgment on Serial Data (SDA) during the 9th bit time. If the device does not match the device select code, it deselects itself from the bus, and goes into Standby mode.

Table 4. Operating modes

Mode	$\overline{RW}$ bit	$\overline{WC}^{(1)}$	Bytes	Initial Sequence
Current Address Read	1	X	1	Start, Device Select, $\overline{RW} = 1$
Random Address Read	0	X	1	Start, Device Select, $\overline{RW} = 0$, Address
	1	X		reStart, Device Select, $\overline{RW} = 1$
Sequential Read	1	X	≥ 1	Similar to Current or Random Address Read
Byte Write	0	V_{IL}	1	Start, Device Select, $\overline{RW} = 0$
Page Write	0	V_{IL}	≤ 16	Start, Device Select, $\overline{RW} = 0$

1. X = V_{IH} or V_{IL} .

Figure 6. Write mode sequences with $\overline{WC} = 1$ (data write inhibited)



3.6 Write operations

Following a Start condition the bus master sends a device select code with the Read/Write bit ($\overline{R/W}$) reset to 0. The device acknowledges this, as shown in [Figure 7](#), and waits for an address byte. The device responds to the address byte with an acknowledge bit, and then waits for the data byte.

When the bus master generates a Stop condition immediately after the Ack bit (in the “10th bit” time slot), either at the end of a Byte Write or a Page Write, the internal Write cycle is triggered. A Stop condition at any other time slot does not trigger the internal Write cycle.

During the internal Write cycle, Serial Data (SDA) and Serial Clock (SCL) are ignored, and the device does not respond to any requests.

3.6.1 Byte Write

After the device select code and the address byte, the bus master sends one data byte. If the addressed location is Write-protected, by Write Control ($\overline{WC}$) being driven High (during the period from the Start condition until the end of the address byte), the device replies to the data byte with NoAck, as shown in [Figure 6](#), and the location is not modified. If, instead, the addressed location is not Write-protected, the device replies with Ack. The bus master terminates the transfer by generating a Stop condition, as shown in [Figure 7](#).

3.6.2 Page Write

The Page Write mode allows up to 16 bytes to be written in a single Write cycle, provided that they are all located in the same page in the memory: that is, the most significant memory address bits are the same. If more bytes are sent than will fit up to the end of the page, a condition known as 'roll-over' occurs. This should be avoided, as data starts to become overwritten in an implementation dependent way.

The bus master sends from 1 to 16 bytes of data, each of which is acknowledged by the device if Write Control ($\overline{WC}$) is Low. If the addressed location is Write-protected, by Write Control ($\overline{WC}$) being driven High (during the period from the Start condition until the end of the address byte), the device replies to the data bytes with NoAck, as shown in [Figure 6](#), and the locations are not modified. After each byte is transferred, the internal byte address counter (the 4 least significant address bits only) is incremented. The transfer is terminated by the bus master generating a Stop condition.

Figure 7. Write mode sequences with $\overline{WC} = 0$ (data write enabled)

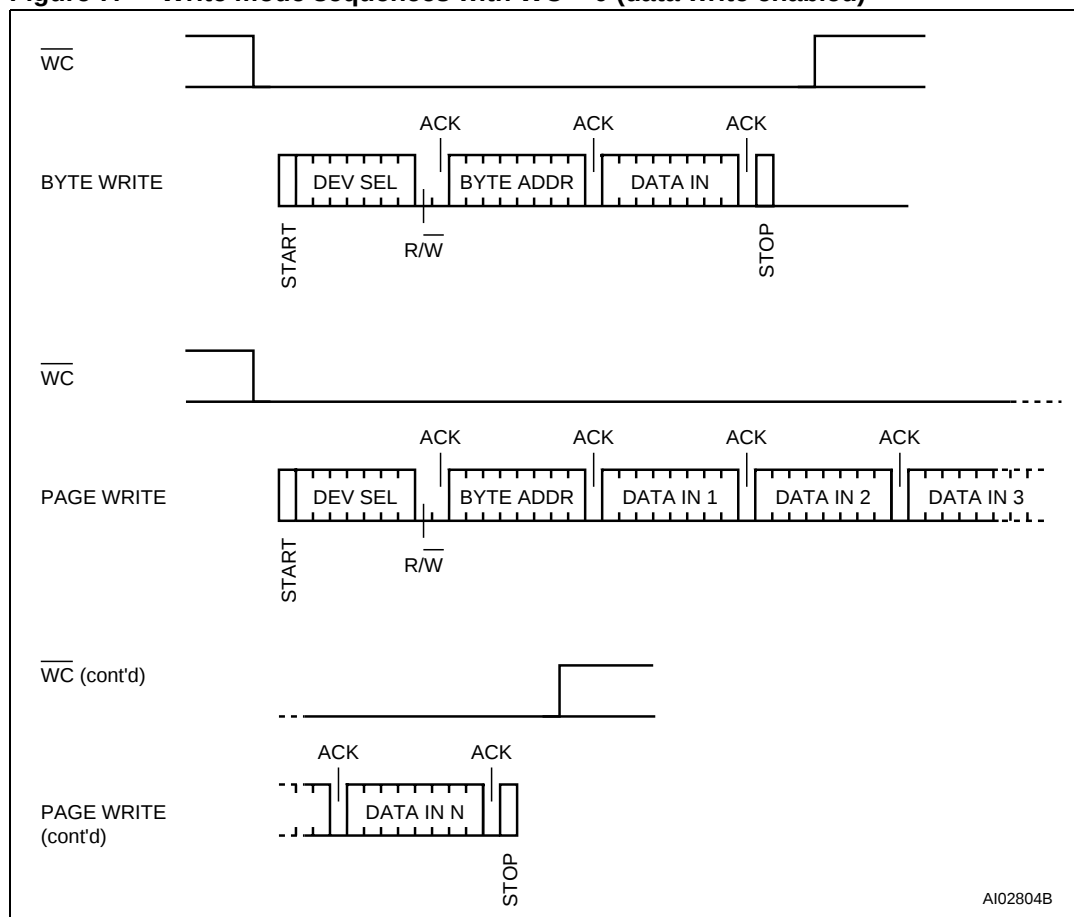
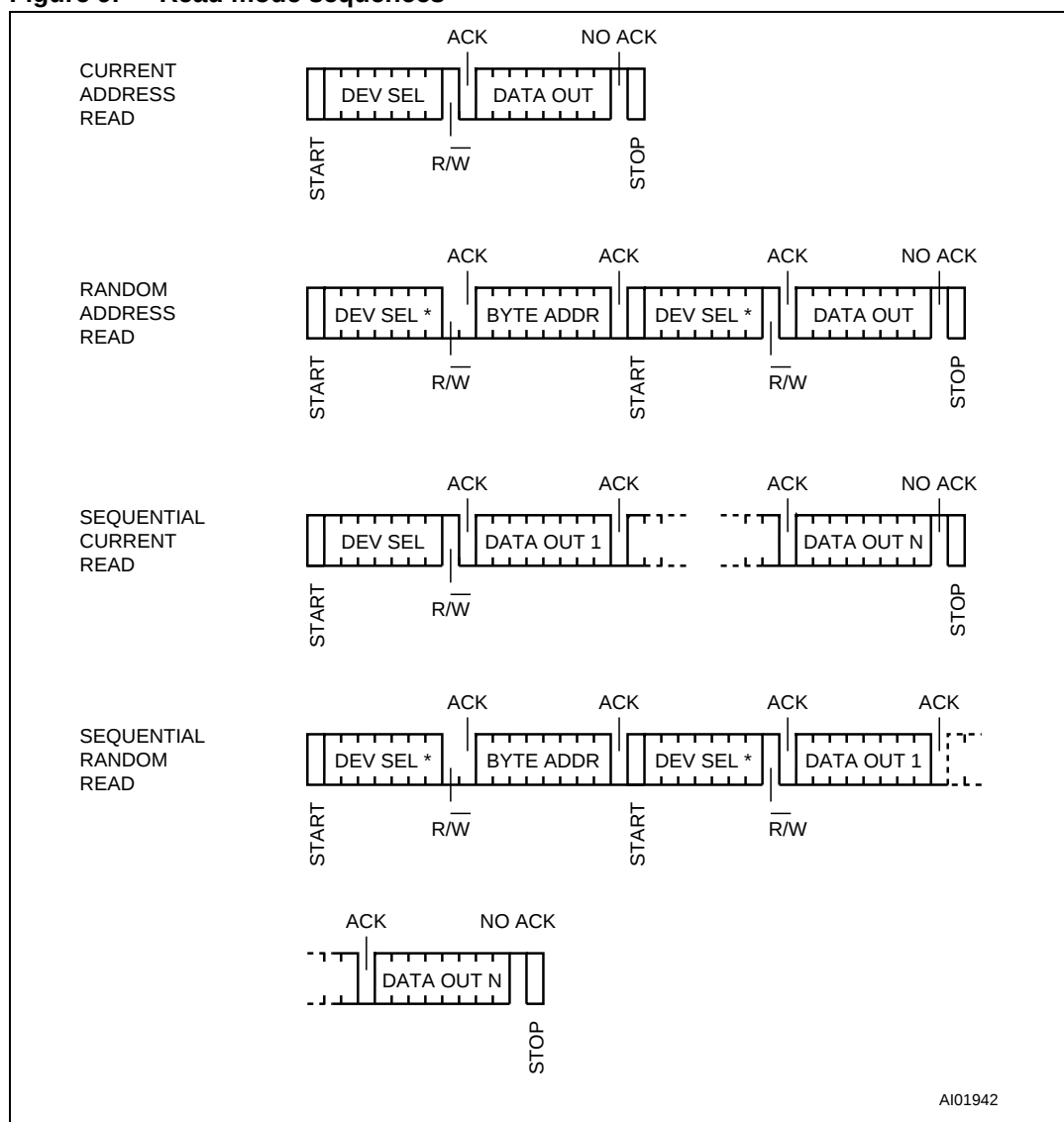


Figure 9. Read mode sequences



1. The seven most significant bits of the device select code of a Random Read (in the 1st and 3rd bytes) must be identical.

3.7 Read operations

Read operations are performed independently of the state of the Write Control ($\overline{WC}$) signal. The device has an internal address counter which is incremented each time a byte is read.

3.7.1 Random Address Read

A dummy Write is first performed to load the address into this address counter (as shown in [Figure 9](#)) but *without* sending a Stop condition. Then, the bus master sends another Start condition, and repeats the device select code, with the Read/Write bit ($\overline{RW}$) set to 1. The device acknowledges this, and outputs the contents of the addressed byte. The bus master must *not* acknowledge the byte, and terminates the transfer with a Stop condition.

3.7.2 Current Address Read

For the Current Address Read operation, following a Start condition, the bus master only sends a device select code with the Read/Write bit (RW) set to 1. The device acknowledges this, and outputs the byte addressed by the internal address counter. The counter is then incremented. The bus master terminates the transfer with a Stop condition, as shown in [Figure 9](#), without acknowledging the byte.

3.7.3 Sequential Read

This operation can be used after a Current Address Read or a Random Address Read. The bus master *does* acknowledge the data byte output, and sends additional clock pulses so that the device continues to output the next byte in sequence. To terminate the stream of bytes, the bus master must *not* acknowledge the last byte, and *must* generate a Stop condition, as shown in [Figure 9](#).

The output data comes from consecutive addresses, with the internal address counter automatically incremented after each byte output. After the last memory address, the address counter 'rolls-over', and the device continues to output data from memory address 00h.

3.7.4 Acknowledge in Read mode

For all Read commands, the device waits, after each byte read, for an acknowledgment during the 9th bit time. If the bus master does not drive Serial Data (SDA) Low during this time, the device terminates the data transfer and switches to its Standby mode.

4 Initial delivery state

The device is delivered with all bits in the memory array set to 1 (each byte contains FFh).

5 Maximum rating

Stressing the device outside the ratings listed in [Table 5](#) may cause permanent damage to the device. These are stress ratings only, and operation of the device at these, or any other conditions outside those indicated in the Operating sections of this specification, is not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability. Refer also to the STMicroelectronics SURE Program and other relevant quality documents.

Table 5. Absolute maximum ratings

Symbol	Parameter	Min.	Max.	Unit
T_A	Ambient operating temperature	-40	130	°C
T_{STG}	Storage temperature	-65	150	°C
T_{LEAD}	Lead temperature during soldering	see note ⁽¹⁾		°C
	PDIP-specific lead temperature during soldering		260 ⁽²⁾	°C
V_{IO}	Input or output range	-0.50	6.5	V
V_{CC}	Supply voltage	-0.50	6.5	V
V_{ESD}	Electrostatic discharge voltage (human body model) ⁽³⁾	-4000	4000	V

1. Compliant with JEDEC Std J-STD-020D (for small body, Sn-Pb or Pb assembly), the ST ECOPACK® 7191395 specification, and the European directive on Restrictions on Hazardous Substances (RoHS) 2002/95/EU.
2. T_{LEAD} max must not be applied for more than 10s.
3. AEC-Q100-002 (compliant with JEDEC Std JESD22-A114A, C1 = 100 pF, R1 = 1500 Ω, R2 = 500 Ω).

Table 10. DC characteristics (M24Cxx-W, device grade 3)

Symbol	Parameter	Test condition (in addition to those in Table 6)	Min.	Max.	Unit
I_{LI}	Input leakage current (SCL, SDA, E0, E1, and E2)	$V_{IN} = V_{SS}$ or V_{CC} , device in Standby mode		± 2	μA
I_{LO}	Output leakage current	$V_{OUT} = V_{SS}$ or V_{CC} , SDA in Hi-Z		± 2	μA
I_{CC}	Supply current	$V_{CC} = 5 V$, $f_C = 400 kHz$ (rise/fall time < 50 ns)		3	mA
		$V_{CC} = 2.5 V$, $f_C = 400 kHz$ (rise/fall time < 50 ns)		3	mA
I_{CC1}	Standby supply current	$V_{IN} = V_{SS}$ or V_{CC} , $V_{CC} = 5 V$		5	μA
		$V_{IN} = V_{SS}$ or V_{CC} , $V_{CC} = 2.5 V$		2	μA
V_{IL}	Input low voltage (SDA, SCL, $\overline{WC}$)		-0.45	$0.3V_{CC}$	V
V_{IH}	Input high voltage (SDA, SCL, $\overline{WC}$)		$0.7V_{CC}$	$V_{CC}+1$	V
V_{OL}	Output low voltage	$I_{OL} = 2.1 mA$ when $V_{CC} = 2.5 V$ or $I_{OL} = 3 mA$ when $V_{CC} = 5.5 V$		0.4	V

Table 11. DC characteristics (M24Cxx-R)

Symbol	Parameter	Test condition (in addition to those in Table 7)	Min.	Max.	Unit
I_{LI}	Input leakage current (SCL, SDA, E0, E1, and E2)	$V_{IN} = V_{SS}$ or V_{CC} , device in Standby mode		± 2	μA
I_{LO}	Output leakage current	$V_{OUT} = V_{SS}$ or V_{CC} , SDA in Hi-Z		± 2	μA
I_{CC}	Supply current	$V_{CC} = 1.8 V$, $f_C = 400 kHz$ (rise/fall time < 50 ns)		0.8	mA
I_{CC1}	Standby supply current	$V_{IN} = V_{SS}$ or V_{CC} , $V_{CC} = 1.8 V$		1	μA
V_{IL}	Input low voltage (SDA, SCL, $\overline{WC}$)	$2.5 V \leq V_{CC}$	-0.45	$0.3 V_{CC}$	V
		$1.8 V \leq V_{CC} < 2.5 V$	-0.45	$0.25 V_{CC}$	V
V_{IH}	Input high voltage (SDA, SCL, $\overline{WC}$)		$0.7V_{CC}$	$V_{CC}+1$	V
V_{OL}	Output low voltage	$I_{OL} = 0.7 mA$, $V_{CC} = 1.8 V$		0.2	V

Table 15. AC characteristics (M24Cxx-W)

Test conditions specified in Table 6 and Table 13					
Symbol	Alt.	Parameter	Min.	Max.	Unit
f_C	f_{SCL}	Clock frequency		400	kHz
t_{CHCL}	t_{HIGH}	Clock pulse width high	600		ns
t_{CLCH}	t_{LOW}	Clock pulse width low	1300		ns
$t_{DL1DL2}^{(1)}$	t_F	SDA fall time	20	300	ns
t_{DXCX}	$t_{SU:DAT}$	Data in setup time	100		ns
t_{CLDX}	$t_{HD:DAT}$	Data in hold time	0		ns
t_{CLQX}	t_{DH}	Data out hold time	200		ns
$t_{CLQV}^{(2)}$	t_{AA}	Clock low to next data valid (access time)	200	900	ns
$t_{CHDX}^{(3)}$	$t_{SU:STA}$	Start condition setup time	600		ns
t_{DLCL}	$t_{HD:STA}$	Start condition hold time	600		ns
t_{CHDH}	$t_{SU:STO}$	Stop condition setup time	600		ns
t_{DHDL}	t_{BUF}	Time between Stop condition and next Start condition	1300		ns
$t_W^{(4)}$	t_{WR}	Write time		5	ms

1. Sampled only, not 100% tested.
2. To avoid spurious Start and Stop conditions, a minimum delay is placed between SCL=1 and the falling or rising edge of SDA.
3. For a reStart condition, or following a Write cycle.
4. Previous devices bearing the process letter "L" in the package marking guarantee a maximum write time of 10 ms. For more information about these devices and their device identification, please ask your ST Sales Office for Process Change Notices PCN MPG/EE/0061 and 0062 (PCEE0061 and PCEE0062).

Table 16. AC characteristics (M24Cxx-R and M24Cxx-F)

Test conditions specified in Table 7 and Table 11					
Symbol	Alt.	Parameter	Min.	Max.	Unit
f_C	f_{SCL}	Clock frequency		400	kHz
t_{CHCL}	t_{HIGH}	Clock pulse width high	600		ns
t_{CLCH}	t_{LOW}	Clock pulse width low	1300		ns
$t_{DL1DL2}^{(1)}$	t_F	SDA fall time	20	300	ns
t_{DXCX}	$t_{SU:DAT}$	Data in setup time	100		ns
t_{CLDX}	$t_{HD:DAT}$	Data in hold time	0		ns
t_{CLQX}	t_{DH}	Data out hold time	200		ns
$t_{CLQV}^{(2)}$	t_{AA}	Clock low to next data valid (access time)	200	900	ns
$t_{CHDX}^{(3)}$	$t_{SU:STA}$	Start condition setup time	600		ns
t_{DLCL}	$t_{HD:STA}$	Start condition hold time	600		ns
t_{CHDH}	$t_{SU:STO}$	Stop condition setup time	600		ns
t_{DHDL}	t_{BUF}	Time between Stop condition and next Start condition	1300		ns
t_W	t_{WR}	Write time		5 ⁽⁴⁾	ms

1. Sampled only, not 100% tested.
2. To avoid spurious Start and Stop conditions, a minimum delay is placed between SCL=1 and the falling or rising edge of SDA.
3. For a reStart condition, or following a Write cycle.
4. $t_W(\text{max}) = 5 \text{ ms}$ (instead of 10 ms) is offered from Week 41 2007. These devices can be identified with the process letter printed on the package:
M24C01: process letter is either S or G
M24C02: process letter is either S or G
M24C04: process letter is Q
M24C08: process letter is Q
M24C016: process letter is either S or Q

Figure 11. AC waveforms

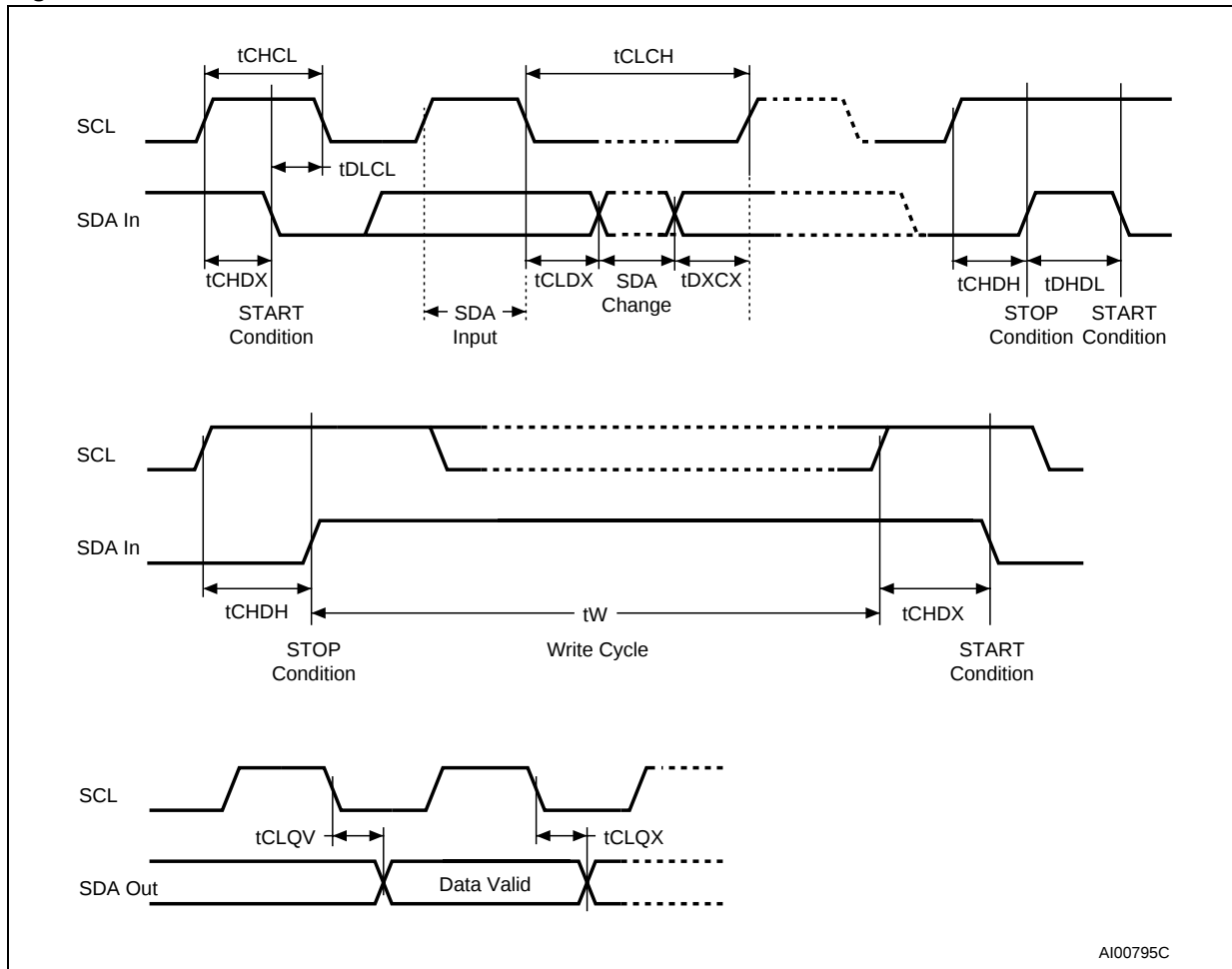
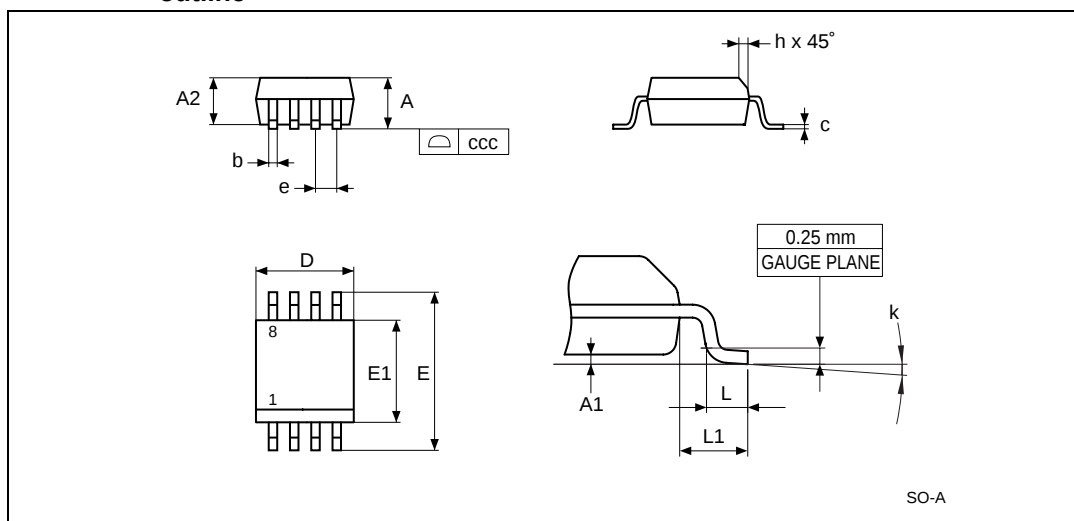


Figure 13. SO8 narrow – 8 lead plastic small outline, 150 mils body width, package outline

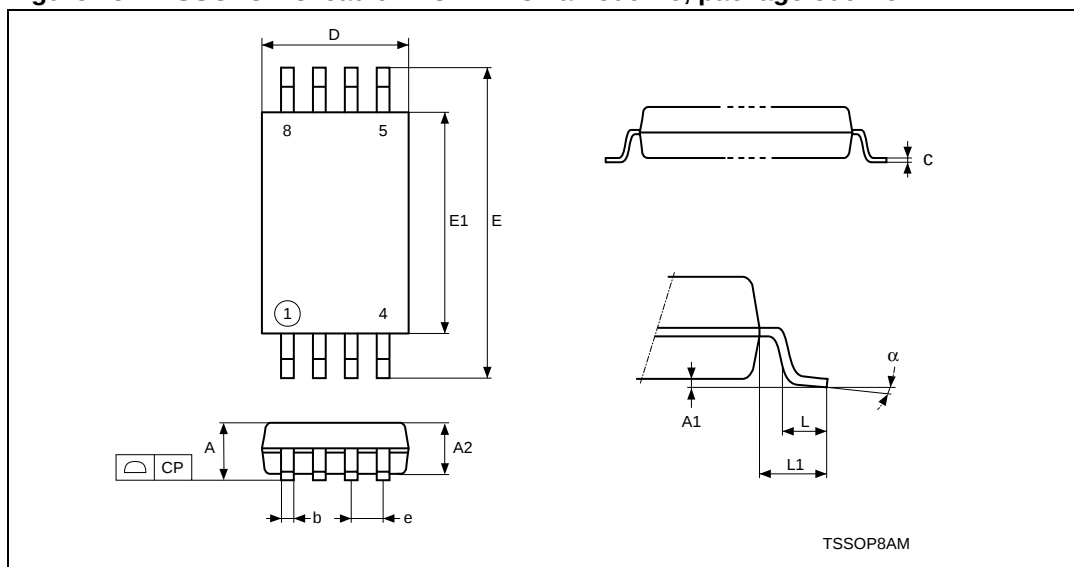


1. Drawing is not to scale.
2. The '1' that appears in the top view of the package shows the position of pin 1 and the 'N' indicates the total number of pins.

Table 18. SO8 narrow – 8 lead plastic small outline, 150 mils body width, package mechanical data

Symbol	millimeters			inches		
	Typ	Min	Max	Typ	Min	Max
A			1.75			0.069
A1		0.10	0.25		0.004	0.010
A2		1.25			0.049	
b		0.28	0.48		0.011	0.019
c		0.17	0.23		0.007	0.009
ccc			0.10			0.004
D	4.90	4.80	5.00	0.193	0.189	0.197
E	6.00	5.80	6.20	0.236	0.228	0.244
E1	3.90	3.80	4.00	0.154	0.150	0.157
e	1.27	–	–	0.050	–	–
h		0.25	0.50		0.010	0.020
k		0°	8°		0°	8°
L		0.40	1.27		0.016	0.050
L1	1.04			0.041		

Figure 15. TSSOP8 – 8 lead thin shrink small outline, package outline



1. Drawing is not to scale.
2. The circle in the top view of the package indicates the position of pin 1.

Table 20. TSSOP8 – 8 lead thin shrink small outline, package mechanical data

Symbol	millimeters			inches		
	Typ.	Min.	Max.	Typ.	Min.	Max.
A			1.200			0.0472
A1		0.050	0.150		0.0020	0.0059
A2	1.000	0.800	1.050	0.0394	0.0315	0.0413
b		0.190	0.300		0.0075	0.0118
c		0.090	0.200		0.0035	0.0079
CP			0.100			0.0039
D	3.000	2.900	3.100	0.1181	0.1142	0.1220
e	0.650	—	—	0.0256	—	—
E	6.400	6.200	6.600	0.2520	0.2441	0.2598
E1	4.400	4.300	4.500	0.1732	0.1693	0.1772
L	0.600	0.450	0.750	0.0236	0.0177	0.0295
L1	1.000			0.0394		
α		0°	8°		0°	8°

8 Part numbering

Table 22. Ordering information scheme

Example:	M24C16	–	W	DW	3	T	P	/S
Device type								
M24 = I ² C serial access EEPROM								
Device Function								
16 = 16 Kbit (2048 x 8)								
08 = 8 Kbit (1024 x 8)								
04 = 4 Kbit (512 x 8)								
02 = 2 Kbit (256 x 8)								
01 = 1 Kbit (128 x 8)								
Operating voltage								
W = V _{CC} = 2.5 V to 5.5 V (400 kHz)								
R = V _{CC} = 1.8 V to 5.5 V (400 kHz)								
F = V _{CC} = 1.7 V to 5.5 V (400 kHz)								
Package								
BN = PDIP8								
MN = SO8 (150 mil width)								
MB = UDFPN8 (MLP8)								
DW = TSSOP8 (169 mil width)								
DS = TSSOP8 (3 x 3 mm body size, MSOP8) ⁽¹⁾								
Device grade								
6 = Industrial: device tested with standard test flow over –40 to 85 °C								
3 = Automotive: device tested with high reliability certified flow ⁽²⁾ over –40 to 125 °C								
5 = Consumer: device tested with standard test flow over –20 to 85 °C.								
Option								
T = Tape and reel packing								
Plating technology								
P or G = ECOPACK® (RoHS compliant)								
Process⁽³⁾								
/S = F6SP36%								

1. Products sold in this package are not recommended for new design.
2. ST strongly recommends the use of the Automotive Grade devices for use in an automotive environment. The High Reliability Certified Flow (HRCF) is described in the quality note QNEE9801. Please ask your nearest ST sales office for a copy.
3. Used only for device grade 3.

For a list of available options (speed, package, etc.) or for further information on any aspect of this device, please contact your nearest ST sales office.

The category of second-level interconnect is marked on the package and on the inner box label, in compliance with JEDEC standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label.

Table 23. Available M24C16 products (package, voltage range, temperature grade)

Package	M24C16-W $V_{CC} = 2.5 \text{ V to } 5.5 \text{ V}$	M24C16-R $V_{CC} = 1.8 \text{ V to } 5.5 \text{ V}$	M24C16-F $V_{CC} = 1.7 \text{ V to } 5.5 \text{ V}$
DIP8 (BN)	Range 6	Range 6	-
SO8N (MN)	Range 6, Range 3	Range 6	-
UFDFPN8 (MB)	-	Range 6	-
TSSOP8 (DW)	Range 6, Range 3	Range 6	Range 5

Table 24. Available M24C08 products (package, voltage range, temperature grade)

Package	M24C08-W $V_{CC} = 2.5 \text{ V to } 5.5 \text{ V}$	M24C08-R $V_{CC} = 1.8 \text{ V to } 5.5 \text{ V}$	M24C08-F $V_{CC} = 1.7 \text{ V to } 5.5 \text{ V}$
DIP8 (BN)	Range 6	-	-
SO8N (MN)	Range 6, Range 3	Range 6	-
UFDFPN8 (MB)	-	Range 6	Range 5
TSSOP8 (DW)	Range 6	Range 6	Range 5
TSSOP8 3 × 3 mm (DS)	-	Range 6	-

Table 25. Available M24C04 products (package, voltage range, temperature grade)

Package	M24C04-W $V_{CC} = 2.5 \text{ V to } 5.5 \text{ V}$	M24C04-R $V_{CC} = 1.8 \text{ V to } 5.5 \text{ V}$	M24C04-F $V_{CC} = 1.7 \text{ V to } 5.5 \text{ V}$
DIP8 (BN)	Range 6	-	-
SO8N (MN)	Range 6, Range 3	Range 6	-
UFDFPN8 (MB)	-	Range 6	Range 5
TSSOP8 (DW)	Range 6, Range 3	Range 6	Range 5

Table 26. Available M24C02 products (package, voltage range, temperature grade)

Package	M24C02-W $V_{CC} = 2.5 \text{ V to } 5.5 \text{ V}$	M24C02-R $V_{CC} = 1.8 \text{ V to } 5.5 \text{ V}$
DIP8 (BN)	Range 6	-
SO8N (MN)	Range 6, Range 3	Range 6
UFDFPN8 (MB)	-	Range 6
TSSOP8 (DW)	Range 6, Range 3	Range 6

Table 27. Available M24C01 products (package, voltage range, temperature grade)

Package	M24C01-W $V_{CC} = 2.5 \text{ V to } 5.5 \text{ V}$	M24C01-R $V_{CC} = 1.8 \text{ V to } 5.5 \text{ V}$
DIP8 (BN)	Range 6	-
SO8N (MN)	Range 6	Range 6
UFDFPN8 (MB)	-	-
TSSOP8 (DW)	Range 6	Range 6
TSSOP8 3 × 3 mm (DS)	-	Range 6

9 Revision history

Table 28. Document revision history

Date	Version	Changes
10-Dec-1999	2.4	TSSOP8 Turned-Die package removed (p 2 and order information) Lead temperature added for TSSOP8 in table 2
18-Apr-2000	2.5	Labelling change to Fig-2D, correction of values for 'E' and main caption for Tab-13
05-May-2000	2.6	Extra labelling to Fig-2D
23-Nov-2000	3.0	SBGA package information removed to an annex document -R range changed to being the -S range, and the new -R range added
19-Feb-2001	3.1	SBGA package information put back in this document Lead Soldering Temperature in the Absolute Maximum Ratings table amended Write Cycle Polling Flow Chart using ACK illustration updated References to PSDIP changed to PDIP and Package Mechanical data updated Wording brought in to line with standard glossary
20-Apr-2001	3.2	Revision of DC and AC characteristics for the -S series
08-Oct-2001	3.3	Ball numbers added to the SBGA connections and package mechanical illustrations
09-Nov-2001	3.4	Specification of Test Condition for Leakage Currents in the DC Characteristics table improved
30-Jul-2002	3.5	Document reformatted using new template. SBGA5 package removed TSSOP8 (3x3mm ² body size) package (MSOP8) added. -L voltage range added
04-Feb-2003	3.6	Document title spelt out more fully. "W"-marked devices with tw=5ms added.
05-May-2003	3.7	-R voltage range upgraded to 400kHz working, and no longer preliminary data. 5V voltage range at temperature range 3 (-xx3) no longer preliminary data. -S voltage range removed. -Wxx3 voltage+temp ranged added as preliminary data.
07-Oct-2003	4.0	Table of contents, and Pb-free options added. Minor wording changes in Summary Description, Power-On Reset, Memory Addressing, Read Operations. V _{IL} (min) improved to -0.45V. t _W (max) value for -R voltage range corrected.
17-Mar-2004	5.0	MLP package added. Absolute Maximum Ratings for V _{IO} (min) and V _{CC} (min) changed. Soldering temperature information clarified for RoHS compliant devices. Device grade information clarified. Process identification letter "G" information added. 2.2-5.5V range is removed, and 4.5-5.5V range is now Not for New Design

Table 28. Document revision history (continued)

Date	Version	Changes
7-Oct-2005	6.0	Product List summary table added. AEC-Q100-002 compliance. Device Grade information clarified. Updated Device internal reset section, Figure 3 , Figure 4 , Table 16 and Table 22 Added ECOPACK® information. Updated $t_W=5\text{ms}$ for the M24Cxx-W.
17-Jan-2006	7.0	Pin numbers removed from silhouettes (see on page 1). Internal Device Reset paragraph moved to below Section 2.4: Supply voltage (V_{CC}) . Section 2.4: Supply voltage (V_{CC}) added below Section 2: Signal description . Test conditions for V_{OL} updated in Table 9 and Table 10 SO8N package specifications updated (see Table 18) New definition of I_{CC1} over the whole V_{CC} range (see Tables 9, 10 and 11).
19-Sep-2006	8	Document converted to new ST template. SO8 and UFDFPN8 package specifications updated (see Section 7: Package mechanical). Section 2.4: Supply voltage (V_{CC}) clarified. I_{LI} value given with the device in Standby mode in Tables 9, 10 and 11 . Information given in Table 16: AC characteristics (M24Cxx-R and M24Cxx-F) are no longer preliminary data.
03-Aug-2007	9	1.7 V to 5.5 V V_{CC} voltage range added (M24C16-F, M24C08-F, M24C04-F part numbers added; Table 8 and Table 12 added). Section 2.4: Supply voltage (V_{CC}) modified. Note 1 updated to latest standard revision in Table 5: Absolute maximum ratings . Rise/fall time conditions for I_{CC} modified in Table 9 , Table 10 and Table 11 . I_{CC1} conditions modified in Table 11: DC characteristics (M24Cxx-R) . Note removed below Table 14: Input parameters . t_W modified for M24Cxx-R in Table 16 , note added. TSSOP8 (DS) package specifications updated (see Table 21 and Figure 16). Added: Table 23 , Table 24 , Table 25 , Table 26 and Table 27 summarizing all available products. Table 22: Ordering information scheme : Blank option removed under Plating technology, /W removed under Process.
27-Sep-2007	10	Section 2.3: Chip Enable ($E0$, $E1$, $E2$) updated. Concerned signals specified for V_{IL} and V_{IH} parameters, and note removed in DC characteristics tables (Table 9 , Table 10 , Table 11 and Table 12). t_W modified in Table 16: AC characteristics (M24Cxx-R and M24Cxx-F) . M24C08-F and M24C04-F offered in UFDFPN8 package in the temperature range 5 (see Table 24 and Table 25).

Please Read Carefully:

Information in this document is provided solely in connection with ST products. STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, modifications or improvements, to this document, and the products and services described herein at any time, without notice.

All ST products are sold pursuant to ST's terms and conditions of sale.

Purchasers are solely responsible for the choice, selection and use of the ST products and services described herein, and ST assumes no liability whatsoever relating to the choice, selection or use of the ST products and services described herein.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted under this document. If any part of this document refers to any third party products or services it shall not be deemed a license grant by ST for the use of such third party products or services, or any intellectual property contained therein or considered as a warranty covering the use in any manner whatsoever of such third party products or services or any intellectual property contained therein.

UNLESS OTHERWISE SET FORTH IN ST'S TERMS AND CONDITIONS OF SALE ST DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY WITH RESPECT TO THE USE AND/OR SALE OF ST PRODUCTS INCLUDING WITHOUT LIMITATION IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION), OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

UNLESS EXPRESSLY APPROVED IN WRITING BY AN AUTHORIZED ST REPRESENTATIVE, ST PRODUCTS ARE NOT RECOMMENDED, AUTHORIZED OR WARRANTED FOR USE IN MILITARY, AIR CRAFT, SPACE, LIFE SAVING, OR LIFE SUSTAINING APPLICATIONS, NOR IN PRODUCTS OR SYSTEMS WHERE FAILURE OR MALFUNCTION MAY RESULT IN PERSONAL INJURY, DEATH, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE. ST PRODUCTS WHICH ARE NOT SPECIFIED AS "AUTOMOTIVE GRADE" MAY ONLY BE USED IN AUTOMOTIVE APPLICATIONS AT USER'S OWN RISK.

Resale of ST products with provisions different from the statements and/or technical features set forth in this document shall immediately void any warranty granted by ST for the ST product or service described herein and shall not create or extend in any manner whatsoever, any liability of ST.

ST and the ST logo are trademarks or registered trademarks of ST in various countries.

Information in this document supersedes and replaces all information previously supplied.

The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners.

© 2007 STMicroelectronics - All rights reserved

STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan - Malaysia - Malta - Morocco - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America

www.st.com